## **Power MOSFET**

## -20 V, -15 A, Single P-Channel, μ8FL

#### **Features**

- Ultra Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- μ8FL 3.3 x 3.3 x 0.8 mm for Space Saving and Excellent Thermal Conduction
- ESD Protection Level of 5 kV per JESD22-A114
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- Battery Switch
- High Side Load Switch
- Optimized for Power Management Applications for Portable Products such as Media Tablets, Ultrabook PCs and Cellphones

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage	V <sub>GS</sub>	±8	V		
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-15	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C		-11	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.3	W
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-22	Α
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 85°C		-16	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.9	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-9	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C	1	-7	
Power Dissipation R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.84	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	-46	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
ESD (HBM, JESD22-A1	V <sub>ESD</sub>	5000	V		
Source Current (Body Di	I <sub>S</sub>	-3	Α		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

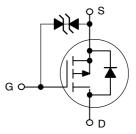


## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
-20 V	6.7 mΩ @ -4.5 V	–15 A	
	9.0 mΩ @ -2.5 V	-137	

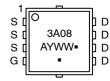
## P-Channel MOSFET





## WDFN8 (μ8FL) CASE 511AB

### **MARKING DIAGRAM**



3A08 = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

## ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>		
NTTFS3A08PZTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel		
NTTFS3A08PZTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	55	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	148	
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	26	

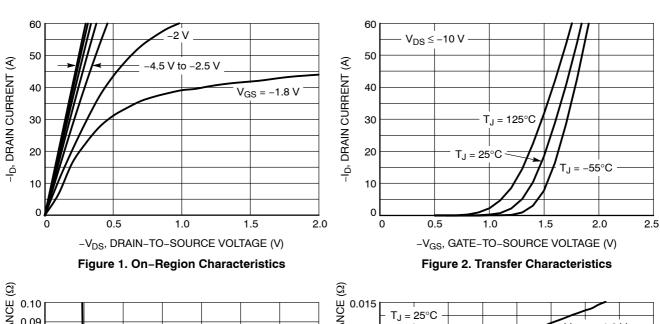
- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

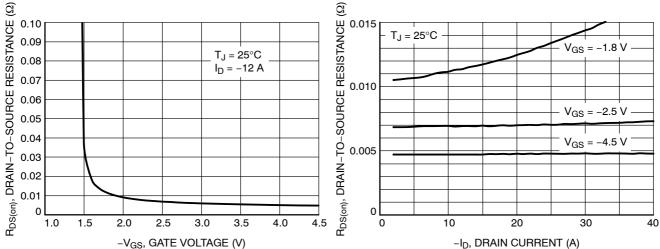
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

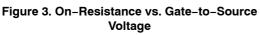
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = -16 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$				-1	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±5 V				±5	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -$	-250 μA	-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -12 A		4.9	6.7	mΩ
		V <sub>GS</sub> = -2.5 V	I <sub>D</sub> = -10 A		6.9	9.0	1
Forward Transconductance	9FS	$V_{DS} = -1.5 \text{ V}, I_{D} = -8 \text{ A}$			62		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -10 V			5000		pF
Output Capacitance	C <sub>oss</sub>				600		]
Reverse Transfer Capacitance	C <sub>rss</sub>				540		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -8 \text{ A}$			56		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.0		
Gate-to-Source Charge	$Q_{GS}$				6.5		
Gate-to-Drain Charge	$Q_{GD}$				15.4		
SWITCHING CHARACTERISTICS (Note	e 6)						
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = -4.5 V, $V_{DS}$ = -10 V, $I_{D}$ = -8 A, $R_{G}$ = 6.0 $\Omega$			13		ns
Rise Time	t <sub>r</sub>				60		
Turn-Off Delay Time	t <sub>d(off)</sub>				250		
Fall Time	t <sub>f</sub>				170		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$ , $I_S = -3 A$	T <sub>J</sub> = 25°C		-0.65	-1.0	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, $d_{IS}/d_t$ = 100 A/ $\mu$ s, $I_S$ = -6 A			207		ns
Charge Time	ta				45		
Discharge Time	t <sub>b</sub>				162		
Reverse Recovery Charge	Q <sub>RR</sub>				234		nC

- 5. Pulse Test: pulse width = 300  $\mu$ s, duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS







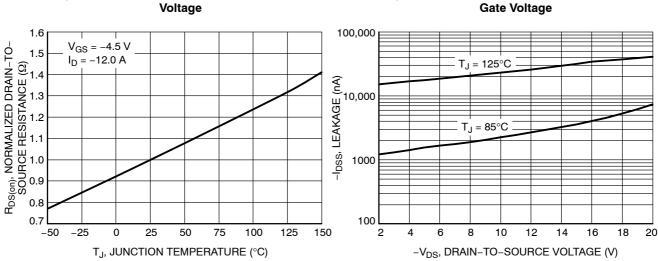


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

Figure 4. On-Resistance vs. Drain Current and

#### **TYPICAL CHARACTERISTICS**

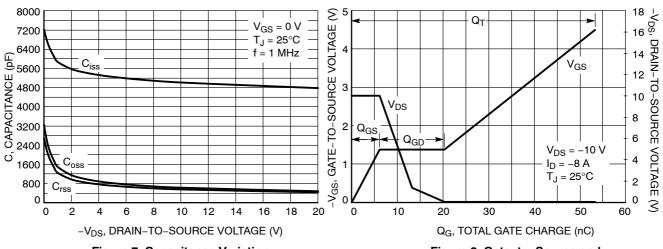
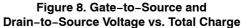


Figure 7. Capacitance Variation



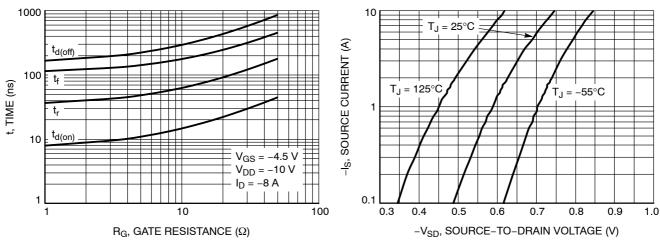


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

400 350 300 250 150 100 50 0 1.E-04 1.E-02 1.E+00 1.E+02 SINGLE PULSE TIME (s)

Figure 10. Diode Forward Voltage vs. Current

 $I_{D} = -250 \,\mu\text{A}$ 

€ 0.65

0.55

0.45

0.35

0.25

0.15

-50

-25

0

25

 $T_{J},\, TEMPERATURE\; (^{\circ}C)$  Figure 11. Threshold Voltage

50

75

100

125

Figure 12. Single Pulse Maximum Power Dissipation

150

## **TYPICAL CHARACTERISTICS**

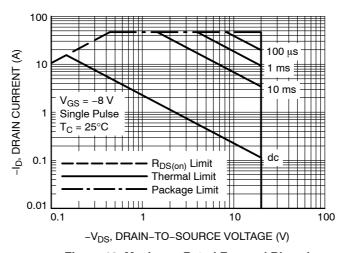


Figure 13. Maximum Rated Forward Biased Safe Operating Area

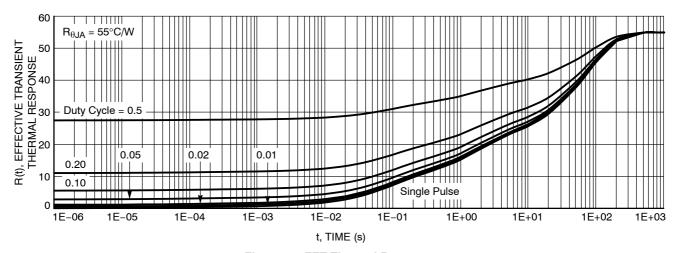
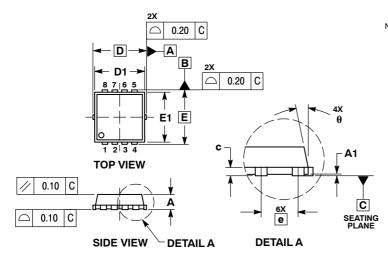


Figure 14. FET Thermal Response

#### PACKAGE DIMENSIONS

#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC		0.026 BSC				
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
Ĺ	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

#### В С Α 0.10 0.05 С e/2 E2 F3 D2 G **BOTTOM VIEW**

## **SOLDERING FOOTPRINT\*** <sup>4X</sup> ┌0.66 PACKAGE OUTLINE 3.60 0.75 0.57 2.30 0.47 2.37 3.46

DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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